



Interference Searched 	Application/Control No. 10026462	Applicant(s)/Patent Under Reexamination TAKEUCHI ET AL.
	Examiner Vincent, Sean E	Art Unit 1731

Class	Sub Class	Date	Examiner
65	29.11 29.18 31 61	3/17/05	SV
73	7	3/17/05	SV

U.S. Patent and Trademark Office	Part of Paper No.: 3-17-05
----------------------------------	----------------------------

<p>Searched</p> 	<p>Application/Control No.</p> <p>10026462</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>TAKEUCHI ET AL.</p>
	<p>Examiner</p> <p>Vincent, Sean E</p>	<p>Art Unit</p> <p>1731</p>

Class	Sub Class	Date	Examiner
All previous searches up to date		3/14/05	SV
73	7	3/14/05	SV

U.S. Patent and Trademark Office	Part of Paper No.: 3-17-05
----------------------------------	----------------------------